U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

ATTORNEY'S DOCKET NUMBER 1454.1220

TRANSMITTAL LETTER TO THE UNITED STATES

	DESIGNATED/ELECT	TED OFFICE (DO/EO/US)	* **
	CONCERNING A FILI	NG UNDER 35 U.S.C. 371	10/049380
	INTERNATIONAL APPLICATION NO. PCT/DE00/02603	INTERNATIONAL FILING DATE 3 August 2000	PRIORITY DATE CLAIMED 12 August 1999
		IE POSITION OR THE SURFACE STR DD AS WELL AS A MACHINE FOR TRE	
	APPLICANT(S) FOR DO/EO/US Dietmar SCHUETZ	5	
	Applicant herewith submits to the items and other information:	e United States Designated/Elected Off	ice (DO/EO/US) the following
		on of items concerning a filing under 35 st to immediately begin national examin	
•	3.	d by the expiration of 19 months from the al Application as filed (35 U.S.C. 371(c) rewith (required only if not transmitted b	(2))
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	Items 10-15 below concern docu	ument(s) or information included:	
	11. An assignment document Please mail the recor	e Statement Under 37 CFR 1.97 and 1. it for recording. ded assignment document to: nose signature, name & address appea	
	12.⊠ A preliminary amendmer 13.⊠ A substitute specification	orney and/or address letter.	
		national Application, copy of cover page Report, and International Preliminary Ex	
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	U.S. National Fee	(35 U.S.C. 371(c)(1)) a	nd other fees as folk	ows:	
CLAIMS	(1) FOR	(2) NUMBER FILED	(3) NUMBER EXTRA	(4) RATE	(5) CALCULATIONS
	TOTAL CLAIMS	8 -20=	0	x \$ 18.00	0.00
	INDEPENDENT CLAIMS	2 -3=	0	x \$ 84.00	0.00
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SUBMITT	ED BY: STAAS & HA	ALSEY LLP			
Type Na	me	Richard A. Gollhofer		Reg. No.	31,106
Signature	e .	Richard a. I	ollholes	Date	2/12/02

Docket No.: 1454.1220

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

Dietmar SCHUETZ

Serial No.

Group Art Unit: (unassigned)

Confirmation No.

Filed: (concurrently)

Examiner: (unassigned)

For: METHOD AND APPARATUS FOR DETECTING POSITION OR SURFACE STRUCTURE OF AN OBJECT (as amended)

PRELIMINARY AMENDMENT

Assistant Commissioner for Patents Washington, D.C. 20231

Sir:

Before examination of the above-identified application, please amend the application as follows:

IN THE TITLE:

Please DELETE the Title in its entirety and REPLACE with the following new Title.

-- METHOD AND APPARATUS FOR DETECTING POSITION OR SURFACE STRUCTURE OF AN OBJECT--.

IN THE SPECIFICATION:

Please REPLACE the pending specification with the substitute specification attached hereto.

IN THE CLAIMS:

Please cancel without prejudice or disclaimer claims 1-6 in the underlying PCT application and ADD new claims 7-14 in accordance with the following:

7. (NEW) A method for detecting at least one of position and surface structure of an object, comprising:

placing the object immediately above an array of capacitive sensors, each having an outer surface with a lateral extent of at most half of a lateral extent of the object; and

electronically evaluating a capacitive disturbance of the outer surface of at least one individual sensor caused by said placing.

- 8. (NEW) The method as claimed in claim 1, further comprising forming an image of the object.
- 9. (NEW) The method as claimed in claim 8, wherein the array is a capacitive fingerprint sensor formed of a semiconductor.
- 10. (NEW) The method as claimed in claim 9, wherein said evaluating detects at least one of the position and surface structure of a mechanical workpiece.
- 11. (NEW) The method as claimed in claim 9, wherein said evaluating detects at least one of the position and surface structure of an electric component
- 12. (NEW) The method as claimed in claim 11, wherein said evaluating detects at least one of the position and surface structure of terminal pins of the electric component.
 - 13. (NEW) The method as claimed in claim 11,

wherein said evaluating detects the position and the orientation of the terminal pins of the electric component in an automatic component mounting machine that has a machine tool and a component provider, and

wherein the array is integrated in at least one of the component provider and the machine tool.

14. (NEW) An apparatus for processing objects with a tool for providing the objects and a tool for transporting the objects, comprising:

a fingerprint sensor, integrated in at least one of the tools, to detect at least one of a position and a surface structure of the objects.

IN THE ABSTRACT:

Please DELETE the Abstract in its entirety and replace with the attached Substitute Abstract.

REMARKS

This Preliminary Amendment is submitted to improve the form of the English translation as filed. It is respectfully requested that this Preliminary Amendment be entered in the above-referenced application.

In accordance with the foregoing, claims 1-6 have been canceled and claims 7-14 have been added. Thus, claims 7-14 are pending and are under consideration.

A substitute specification is also being filed herewith. The substitute specification is accompanied by a marked-up copy of the original specification.

If there are any questions regarding these matters, such questions can be addressed by telephone to the undersigned. Otherwise, an early action on the merits is respectfully solicited.

If any further fees are required in connection with the filing of this Preliminary Amendment, please charge same to our Deposit Account No. 19-3935.

Respectfully submitted,

STAAS & HALSEY LLP

Date: 2/12/02

Richard A. Gollhofer

Registration No. 31,106

700 Eleventh Street, NW, Suite 500 Washington, D.C. 20001 (202) 434-1500

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JC13 Rec'd PCT/PTC 1 2 FEB 2002

SUBSTITUTE SPECIFICATION

TITLE OF THE INVENTION

METHOD AND APPARATUS FOR DETECTING POSITION OR SURFACE STRUCTURE OF AN OBJECT

CROSS REFERENCE TO RELATED APPLICATIONS

[0001] This application is based on and hereby claims priority to German Application No. 19938062.7 filed on August 12, 1999, the contents of which are hereby incorporated by reference.

BACKGROUND OF THE INVENTION

[0002] The invention relates to a method for detecting the position or the surface structure of an object, an image of the object being generated. The invention also relates to the use of the method.

[0003] Machine tools, in particular automatic component mounting machines, place stringent requirements on accuracy during the detection, handling and processing of workpieces or components. An important problem in this is inaccuracies in the provision of the workpieces/components, which arise, for example, from a necessary play between the component and component support. These inaccuracies are generally larger than the required maximum final inaccuracy, and must therefore be corrected in the course of being processed. In particular, in addition to determining the position of the workpiece or component, it is desirable to detect whether it is damaged on the outside and must therefore be excluded straight away from further processing.

[0004] Methods for detecting workpieces/components are known which scan the latter optically and compose a corresponding two-dimensional image containing information from the third dimension (depth information). The optical sensors required for this purpose are complicated and expensive to produce. Because of their complicated design, they are difficult to integrate and can therefore be arranged only at specific stations in the processing cycle from the provision of the component up to final placement.

[0005] Consequently, these known methods are typified by subsequent correction, for example of the position of the component, or the rejection of the component as scrap. This procedure leads to not inconsiderable time losses, particularly in the case of automatic component mounting machines. Furthermore, the optical scanning of the workpieces delivers a two-dimensional image with a plenitude of information from the third dimension as well, which is not needed at all in most cases. What is important in essence is to check the position of a workpiece. Moreover, in the case of automatic component mounting machines it is necessary to inspect those parts of the component that later come to lie in the plane of the printed circuit board. An example of this would be the detection of a bent terminal pin of an electric component.

[0006] Moreover, capacitive fingerprint sensors are known which, by scanning the surface of a finger, generate an image of the fingerprint that can be used to identify a person. These sensors are easy and inexpensive to produce with the aid of silicon technology and can be integrated, in addition. Such sensors are disclosed, for example, in U.S. Patent No. 4,353,056.

SUMMARY OF THE INVENTION

[0007] It is the object of the present invention to provide a method for detecting the position or the surface structure of an object in the case of which a sensor that can be produced easily and inexpensively is used to generate an image of the object that for the most part contains only the relevant information.

[0008] The invention specifies a method for detecting the position or the surface structure of an object, the object being placed on or right over an array of capacitive individual sensors. The lateral extent of the individual sensors may in this case be at most half the lateral extent of the object to be detected. At least one of the capacitive individual sensors experiences a capacitive disturbance at its surface through the presence of the object. This disturbance of one or more individual sensors is evaluated electronically and processed to form an image of the object.

[0009] As a result of the placement according to the invention of an object on or right over an array of capacitive individual sensors, the image, delivered by the array, of the object contains only a small amount of depth information on the parts of the object that are located near the sensor. The point is that with increasing distance from the capacitive sensor the capacitive disturbance becomes so slight that it can be detected only weakly, or even no longer. Furthermore, disturbances in the image processing owing to lighting problems or inhomogeneous

backgrounds are eliminated. The components near the sensor emerge clearly in the image, while elements further removed which therefore are also situated outside the plane of the printed circuit board, for example, appear less clearly or not at all. In addition, in the simplest case a capacitive sensor is an arrangement of individual capacitors that can be realized easily and cost-effectively.

[0010] It is particularly advantageous to use a capacitive fingerprint sensor based on a semiconductor as the array of capacitive individual sensors. In this case, the capacitive individual sensors are field effect transistors. Such a sensor can be produced cost-effectively and in an integrated fashion using the means of silicon technology.

[0011] The method according to the invention is suitable, in particular, for applications in which the surface structure or position of a mechanical workpiece or an electric component as object is detected. Particularly in the case of electric components, the method according to the invention is suitable for detecting the position and the orientation of terminal pins, since here there is a need only for the information on the plane of the printed circuit board provided for the component.

[0012] The method according to the invention is particularly well suited for application in automatic component mounting machines that have a machine tool and a component provider. The fingerprint sensors, which can easily be integrated, can be mounted straight away at the component provider or in the machine tool. This renders it possible to check the position and the orientation of terminal pins of electric components at the very beginning of the processing cycle, such that it is possible to dispense with subsequent corrections. In addition, it is possible thereby to exclude defective components, for example those with broken off or bent terminal pins, at once without unnecessarily losing cycle time for a defective component.

[0013] If appropriate, it is also possible to integrate in the automatic component mounting machines further similar or different sensors, for example for detecting the surface structure of the front and rear sides or for simultaneously detecting position and surface structure.

[0014] The invention also specifies a machine for processing objects which has a tool for providing the objects and a tool for transporting the objects. Integrated in one or both tools is an array of capacitive individual sensors that detects the position and/or the surface structure of the objects in accordance with the method described above.

BRIEF DESCRIPTION OF THE DRAWINGS

[0015] These and other objects and advantages of the present invention are explained in more detail below with the aid of an exemplary embodiment and the associated figures, in which:

Figure 1 is a plan view of an object that is placed according to the invention over a fingerprint sensor, and

Figure 2 is a cross section of the object of Figure 1 placed over a fingerprint sensor.

DETAILED DESCRIPTION OF THE PREFERRED EMBODIMENT

[0016] Reference will now be made in detail to the preferred embodiments of the present invention, examples of which are illustrated in the accompanying drawings, wherein like reference numerals refer to like elements throughout.

[0017] Figure 1 shows an electric component 3 with terminal pins 4, which is positioned over a sensor array 1. The sensor array 1 consists of a plurality of capacitive individual sensors 2. The lateral extent of the capacitive individual sensors 2 is substantially smaller than the lateral extent of electric component 3. This ensures that an image of the electric component 3 of adequate resolution is produced.

[0018] Figure 2 shows an electric component 3 with terminal pins 4 that is arranged right next to a sensor array 1. The sensor array 1 consists of capacitive individual sensors 2. Connected to the sensor array is an electronic evaluation system 5 with downstream image processing 6. When applied to the detection of the orientation of terminal pins of electric components, the method according to the invention can be used, for example, to detect the bent away terminal pin illustrated at the bottom in Figure 2 and to exclude the electric component 3 from the further processing cycle as scrap.

[0019] The invention has been described in detail with particular reference to preferred embodiments thereof and examples, but it will be understood that variations and modifications can be effected within the spirit and scope of the invention.

SUBSTITUTE ABSTRACT

METHOD AND APPARATUS FOR DETECTING POSITION OR SURFACE STRUCTURE OF AN OBJECT

The position or surface structure of an object is detected with the aid of an array of capacitive individual sensors, the object being positioned on or right over the array. The method is particularly useful in automatic component mounting machines for detecting position and orientation of the terminal pins of an electric component. The sensor array used in the method is produced using semiconductor fabrication and does not require accessory units such as an optical system.

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Description

Method for detecting the position or the surface structure of an object, and application of the method as well as a machine for processing objects

The invention relates to a method for detecting the position or the surface structure of an object, an image of the object being generated. The invention also relates to the use of the method.

particular automatic component Machine tools, in mounting machines, place stringent requirements accuracy during the detection, handling and processing of workpieces or components. An important problem in the provision of inaccuracies in workpieces/components, which arise, for example, from a necessary play between the component and component support. These inaccuracies are generally larger than required maximum final inaccuracy, and course of corrected in the therefore be processed. In particular, in addition to determining the position of the workpiece or component, desirable to detect whether it is damaged on the outside and must therefore be excluded straight away from further processing.

Methods for detecting workpieces/components are known latter optically and compose which scan the 30 two-dimensional image containing corresponding dimension (depth from the third information information). The optical sensors required for this complicated and expensive to produce. purpose are Because of their complicated design, they are difficult to integrate and can therefore be arranged only at specific stations in the processing cycle from the provision of the component up to final placement.

Consequently, these known methods are typified by subsequent correction, for example of the position of the component, or the rejection of the component as scrap. This

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procedure leads to not inconsiderable time losses, particularly in the case of automatic component mounting machines. Furthermore, the optical scanning of the workpieces delivers a two-dimensional image with a plenitude of information from the third dimension as well, which is not needed at all in most cases. What is important in essence is to check the position of a workpiece. Moreover, in the case of automatic component mounting machines it is necessary to inspect those parts of the component that later come to lie in the plane of the printed circuit board. An example of this would be the detection of a bent terminal pin of an electric component.

Moreover, capacitive fingerprint sensors are known which, by scanning the surface of a finger, generate an image of the fingerprint that can be used to identify a person. These sensors are easy and inexpensive to produce with the aid of silicon technology and can be integrated, in addition. Such sensors are disclosed, for example, in US 4,353,056.

It is the object of the present invention to provide a method for detecting the position or the surface structure of an object in the case of which a sensor that can be produced easily and inexpensively is used to generate an image of the object that for the most part contains only the relevant information.

30 This object is achieved according to the invention by a method as claimed in claim 1. Advantageous refinements of the invention and applications of the invention as well as a machine that uses the invention are to be gathered from the further claims.

The invention specifies a method for detecting the position or the surface structure of an object, the object being placed on or right over an array of

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capacitive individual sensors. The lateral extent of the

individual sensors may in this case be at most half the lateral extent of the object to be detected. At least one of the capacitive individual sensors experiences a capacitive disturbance at its surface through the presence of the object. This disturbance of one or more individual sensors is evaluated electronically and processed to form an image of the object.

As a result of the placement according to the invention of an object on or right over an array of capacitive individual sensors, the image, delivered by the array, of the object contains only a small amount of depth information on the parts of the object that are located near the sensor. The point is that with increasing distance from the capacitive sensor the capacitive disturbance becomes so slight that it can be detected weakly, or even no longer. Furthermore, disturbances in the image processing owing to lighting problems or inhomogeneous backgrounds are eliminated. The components near the sensor emerge clearly in the image, while elements further removed which therefore are also situated outside the plane of the printed circuit board, for example, appear less clearly or not at all. In addition, in the simplest case a capacitive sensor is an arrangement of individual capacitors that can be realized easily and cost-effectively.

It is particularly advantageous to use a capacitive fingerprint sensor based on a semiconductor as the array of capacitive individual sensors. In this case, the capacitive individual sensors are field effect transistors. Such a sensor can be produced costeffectively and in an integrated fashion using the means of silicon technology.

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The method according to the invention is suitable, in particular, for applications in which the surface structure or position of a mechanical workpiece or an

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electric component as object is detected. Particularly in the case of electric components, the method according to the invention is suitable for

detecting the position and the orientation of terminal pins, since here there is a need only for the information on the plane of the printed circuit board provided for the component.

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The method according to the invention is particularly well suited for application in automatic component mounting machines that have a machine tool and a component provider. The fingerprint sensors, which can easily be integrated, can be mounted straight away at the component provider or in the machine tool. This renders it possible to check the position and the orientation of terminal pins of electric components at the very beginning of the processing cycle, such that it is possible to dispense with subsequent corrections. is possible thereby to addition, it defective components, for example those with broken off or bent terminal pins, at once without unnecessarily losing cycle time for a defective component.

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If appropriate, it is also possible to integrate in the automatic component mounting machines further similar or different sensors, for example for detecting the surface structure of the front and rear sides or for simultaneously detecting position and surface structure.

The invention also specifies a machine for processing objects which has a tool for providing the objects and a tool for transporting the objects. Integrated in one or both tools is an array of capacitive individual sensors that detects the position and/or the surface structure of the objects in accordance with the method described above.

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The invention is explained in more detail below with the aid of an exemplary embodiment and the associated figures, in which: Figure 1 shows a plan view of an object that is placed according to the invention over a fingerprint sensor, and

Figure 2 shows a cross section of the object of Figure 1 placed over a fingerprint sensor.

Figure 1 shows an electric component 3 with terminal pins 4, which is positioned over a sensor array 1. The sensor array 1 consists of a plurality of capacitive individual sensors 2. The lateral extent of the capacitive individual sensors 2 is substantially smaller than the lateral extent of electric component 3. This ensures that an image of the electric component 3 of adequate resolution is produced.

Figure 2 shows an electric component 3 with terminal pins 4 that is arranged right next to a sensor array 1. The sensor array 1 consists of capacitive individual sensors 2. Connected to the sensor array electronic evaluation system 5 with downstream image processing 6. When applied to the detection of the orientation of terminal pins of electric components, the method according to the invention can be used, for example, to detect the bent away terminal illustrated at the bottom in Figure 2 and to exclude the electric component 3 from the further processing cycle as scrap.

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The invention is not restricted to the special embodiments shown by way of example, but is defined in its most general form by claim 1.

Patent claims

- 1. A method for detecting the position and/or the surface structure of an object (3)
 - in which the object (3) is placed on or right over an array (1) of capacitive individual sensors (2) whose lateral extent is at most half the lateral extent of the object (3) to be detected,
- the capacitive disturbance of the surface of at least one individual sensor (2) thereby being caused, which is evaluated electronically and processed to form an image of the object (3).
- The method as claimed in claim 1, in which the array
 is a capacitive fingerprint sensor based on a semiconductor.
- 3. An application of the method as claimed in claim 1 20 or 2, in which the position or surface structure of a mechanical workpiece or an electric component is detected.
- 4. The application of the method as claimed in claim 3 for detecting the position and the orientation of terminal pins (4) of an electric component (3).
- 5. The application of the method as claimed in claim 3 for detecting the position and the orientation of terminal pins (4) of an electric component (3) in an automatic component mounting machine that has a machine tool and a component provider, the fingerprint sensor being integrated in the component provider or in the machine tool.

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6. A machine for processing objects with the aid of a tool for providing the objects and a tool for transporting the objects, in which there is integrated

in one or both tools a fingerprint sensor which detects the position and/or the surface structure of the objects.

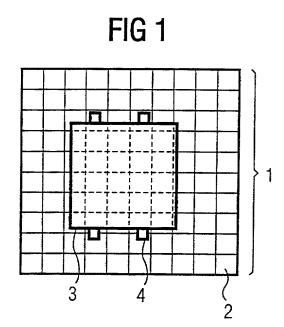
Abstract

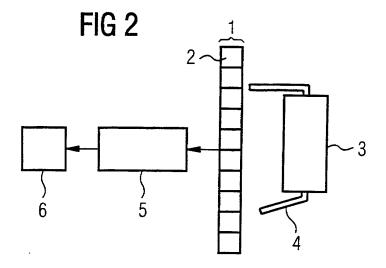
Method for detecting the position or the surface structure of an object, and application of the method as well as a machine for processing objects

The invention relates to a method for detecting the position or the surface structure of an object (3) with the aid of an array (1) of capacitive individual sensors (2), the object (3) being positioned on or right over the array (1). The invention also relates, in particular, to the application of the method in automatic component mounting machines for detecting position and orientation of the terminal pins (4) of an electric component (3). The sensor used in the method produced using the means of semiconductor fabrication and manages without further accessory units such as, for example, an optical system, substantially more favorable to produce. The invention also relates to a machine for processing objects.

Figure 2

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Declaration and Power of Attorney For Patent Application Erklärung Für Patentanmeldungen Mit Vollmacht

German Language Declaration

Als nachstehend	benannter	Erfinder	erkläre	ich	hiermit
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As a below named inventor, I hereby declare that:

dass mein Wohnsitz, meine Postanschrift, und meine Staatsangehörigkeit den im Nachstehenden nach meinem Namen aufgeführten Angaben entsprechen, My residence, post office address and citizenship are as stated below next to my name,

dass ich, nach bestem Wissen der ursprüngliche, erste und alleinige Erfinder (falls nachstehend nur ein Name angegeben ist) oder ein ursprünglicher, erster und Miterfinder (falls nachstehend mehrere Namen aufgeführt sind) des Gegenstandes bin, für den dieser Antrag gestellt wird und für den ein Patent beantragt wird für die Erfindung mit dem Titel:

I believe I am the original, first and sole inventor (if only one name is listed below) or an original, first and joint inventor (if plural names are listed below) of the subject matter which is claimed and for which a patent is sought on the invention entitled

Verfahren zum Erkennen der Lage oder der Oberflächenstruktur eines Gegenstandes und Anwendung des Verfahrens sowie eine Maschine zur Verarbeitung von Gegenständen

Method for detecting the position or the surface structure of an object and application of said method as well as a machine for treating objects

deren Beschreibung

(zutreffendes ankreuzen)

hier beigefügt ist.

am 03.08.2000 als

PCT internationale Anmeldung

PCT Anmeldungsnummer PCT/DE00/02603

eingereicht wurde und am

abgeändert wurde (falls tatsächlich abgeändert).

the specification of which

(check one)

is attached hereto.

☑ was filed on 03.08.2000 as

PCT international application

PCT Application No. PCT/DE00/02603

and was amended on ____

(if applicable)

Ich bestätige hiermit, dass ich den Inhalt der obigen Patentanmeldung einschliesslich der Ansprüche durchgesehen und verstanden habe, die eventuell durch einen Zusatzantrag wie oben erwähnt abgeändert wurde.

I hereby state that I have reviewed and understable the contents of the above identified specification, including the claims as amended by any amendment referred to above.

Ich erkenne meine Pflicht zur Offenbarung irgendwelcher Informationen, die für die Prüfung der vorliegenden Anmeldung in Einklang mit Absatz 37, Bundesgesetzbuch, Paragraph 1.56(a) von Wichtigkeit sind, an.

I acknowledge the duty to disclose information which is material to the examination of this application in accordance with Title 37, Code of Federal Regulations, §1.56(a).

Ich beanspruche hiermit ausländische Prioritätsvorteile gemäss Abschnitt 35 der Zivilprozessordnung der Vereinigten Staaten, Paragraph 119 aller unten angegebenen Auslandsanmeldungen für ein Patent oder eine Erfindersurkunde, und habe auch alle Auslandsanmeldungen für ein Patent oder eine Erfindersurkunde nachstehend gekennzeichnet, die ein Anmeldedatum haben, das vor dem Anmeldedatum der Anmeldung liegt, für die Priorität beansprucht wird.

I hereby claim foreign priority benefits under Title 35, United States Code, §119 of any foreign application(s) for patent or inventor's certificate listed below and have also identified below any foreign application for patent or inventor's certificate having a filing date before that of the application on which priority is claimed:

		German Langu	age Declaration		
Prior foreign app Priorität beanspi	pplications rucht			<u>Priori</u>	ity Claimed
19938062.7 (Number) (Nummer)	<u>DE</u> (Country) (Land)	12.08.1999 (Day Month Yo (Tag Monat Ja	ear Filed) hr eingereicht)	⊠ Yes Ja	□ No Nein
(Number) (Nummer)	「(Country) (Land)	(Day Month Ye (Tag Monat Ja	ear Filed) hr eingereicht)	☐ Yes Ja	□ No Nein
(Number) (Nummer)	Country) (Land)	(Day Month Ye (Tag Monat Ja	ear Filed) hr eingereicht)	Yes Ja	□ No Nein
prozessordnung 120, den Vorzu dungen und falls dieser Anmeld amerikanischen Paragraphen des der Vereinigten s erkenne ich gen Paragraph 1.56(a Informationen ar der früheren Anm	Patentanmeldung las Absatzes 35 der Zin Staaten, Paragraph näss Absatz 37, Bu a) meine Pflicht zur den dem nationaliteten dem nationaliteten dies Anmeldedatum dies	aten, Paragraph eführten Anmel- jedem Anspruch einer früheren aut dem ersten /ilprozeßordnung 122 offenbart ist, ndesgesetzbuch, Offenbarung von Anmeldedatum	I hereby claim the be Code. §120 of any below and, insofar as claims of this applica United States applicathe first paragraph of §122, I acknowledge information as define Regulations, §1.56(a) date of the prior appinternational filing dat	United States as the subject mation is not disation in the mof Title 35, Ure the duty to the difference of the occurrection and the state of the subject of	application(s) listed atter of each of the closed in the prior anner provious d by nited States Code, disclose material Code of Federal between the filing the national or PCT
PCT/DE00/02603 (Application Serial No. (Anmeldeseriennumm) (Fili	.08.2000 ng Date D, M, Y) meldedatum T, M, J)	<u>anhängig</u> (Status) (patentiert, anhängig, aufgegeben)	(; ()	<u>pending</u> Status) patented, pending, bandoned)
(Application Serial No. (Anmeldeseriennumme	, , , , , , , , , , , , , , , , , , , ,	ng Date D,M,Y) meldedatum T, M; J)	(Status) (patentiert, anhängig, aufgeben)	i)	Status) patented, pending, bandoned)
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